

ROUND TYPE LED LAMPS



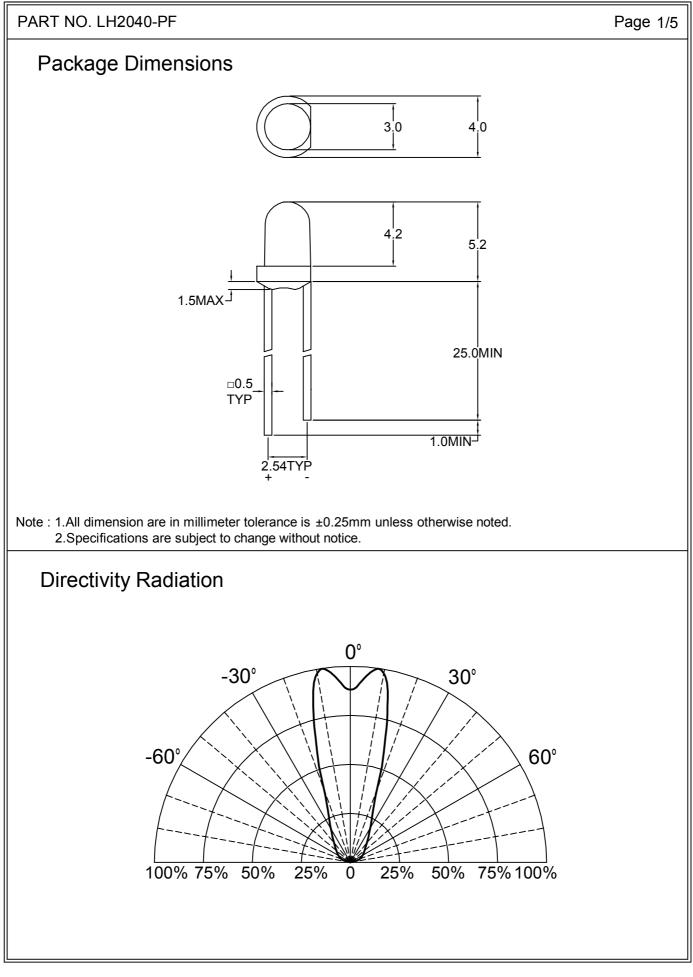
LH2040-PF

DATA SHEET

- DOC. NO : QW0905-LH2040-PF
- REV. : <u>A</u>
- DATE : 08 Aug. 2005









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Absolute Maximum Ratings at Ta=25

Devenueter	Symbol	Ratings	UNIT	
Parameter	Symbol	н		
Forward Current	lF	15	mA	
Peak Forward Current Duty 1/10@10KHz	IFP	60	mA	
Power Dissipation	PD	40	mW	
Reverse Current @5V	lr	10	μA	
Operating Temperature	Topr	-40 ~ +85		
Storage Temperature	Tstg	-40 ~ +100		
Soldering Temperature	Tsol	Max 260 for 5 sec Max (2mm from body)		

Typical Electrical & Optical Characteristics (Ta=25)

PART NO	MATERIAL	COLOR Emitted Lens		Peak Spectral wave halfwidth length nm Pnm		Forward voltage @20mA(V)		Luminous intensity @10mA(mcd)		Viewing angle 2 1/2 (deg)
						Min.	Max.	Min.	Тур.	
LH2040-PF	GaP	Red	Red Diffused	697	90	1.7	2.6	3.0	4.5	36

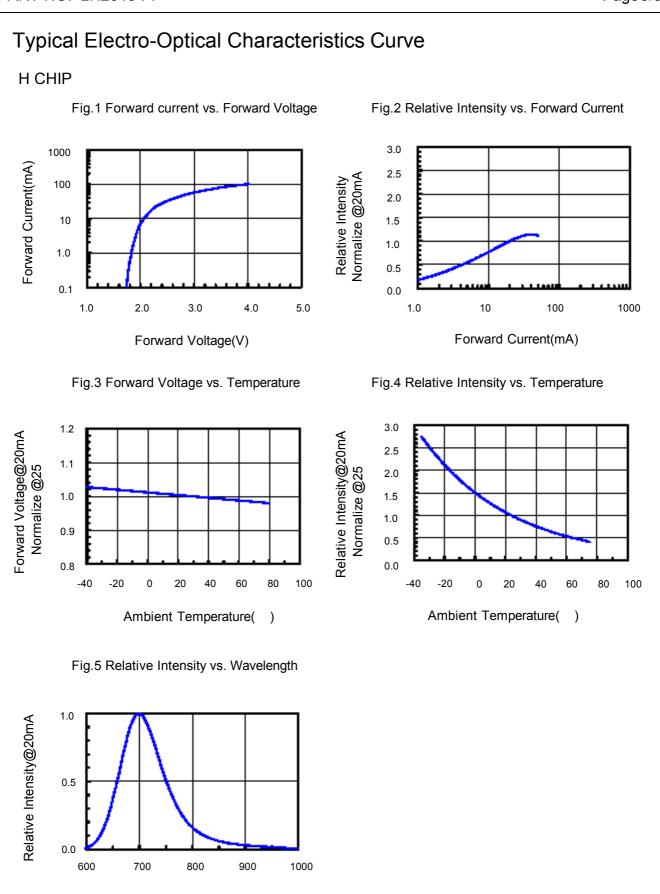
Note : 1.The forward voltage data did not including $\pm 0.1V$ testing tolerance.

2. The luminous intensity data did not including $\pm 15\%$ testing tolerance.



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Wavelength (nm)



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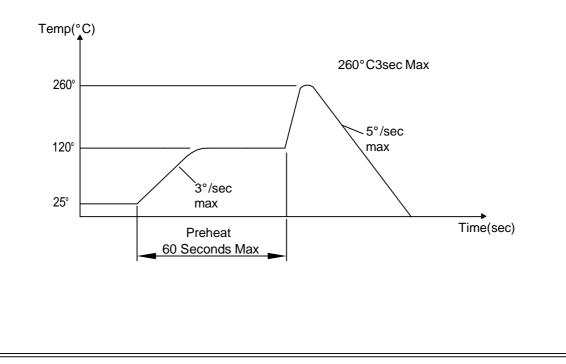
Soldering Condition(Pb-Free)

1.Iron:

Soldering Iron:30W Max Temperature 350 °C Max Soldering Time:3 Seconds Max(One Time) Distance:2mm Min(From solder joint to case)

2.Wave Soldering Profile

Dip Soldering Preheat: 120°C Max Preheat time: 60seconds Max Ramp-up 3°C/sec(max) Ramp-Down:-5°C/sec(max) Solder Bath:260°C Max Dipping Time:3 seconds Max Distance:2mm Min(From solder joint to case)





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Reliability Test:

Test Item	Test Condition	Description	Reference Standard
Operating Life Test	1.Under Room Temperature 2.If=20mA 3.t=1000 hrs (-24hrs, +72hrs)	This test is conducted for the purpose of detemining the resisance of a part in electrical and themal stressed.	MIL-STD-750: 1026 MIL-STD-883: 1005 JIS C 7021: B-1
High Temperature Storage Test	1.Ta=105 ±5 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under ondition of high temperature for hours.	MIL-STD-883:1008 JIS C 7021: B-10
Low Temperature Storage Test	1.Ta=-40 ±5 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of low temperature for hours.	JIS C 7021: B-12
High Temperature High Humidity Test	1.Ta=65 ±5 2.RH=90 %~95% 3.t=240hrs ±2hrs	The purpose of this test is the resistance of the device under tropical for hous.	MIL-STD-202:103B JIS C 7021: B-11
Thermal Shock Test	1.Ta=105 ±5 &-40 ±5 (10min) (10min) 2.total 10 cycles	The purpose of this is the resistance of the device to sudden extreme changes in high and low temperature.	MIL-STD-202: 107D MIL-STD-750: 1051 MIL-STD-883: 1011
Solder Resistance Test	1.T.Sol=260 ±5 2.Dwell time= 10 ±1sec.	This test intended to determine the thermal characteristic resistance of the device to sudden exposures at extreme changes in temperature when soldering the lead wire.	MIL-STD-202: 210A MIL-STD-750: 2031 JIS C 7021: A-1
Solderability Test	1.T.Sol=230 ±5 2.Dwell time=5 ±1sec	This test intended to see soldering well performed or not.	MIL-STD-202: 208D MIL-STD-750: 2026 MIL-STD-883: 2003 JIS C 7021: A-2



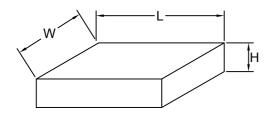
PACKING SPECIFICATION

1.1000 PCS / BAG

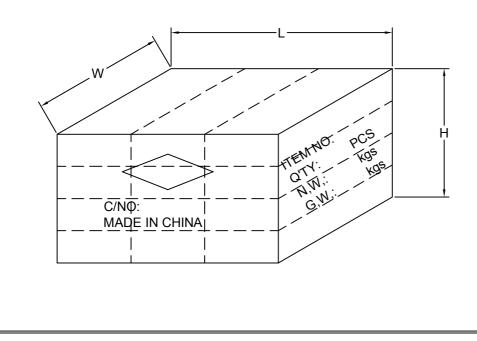


2.8 BAG / INNER BOX

SIZE : L X W X H 33.5cm X 19cm X 7.5cm



- 3. 12 INNER BOXES / CARTON
 - SIZE : L X W X H 58.5cm X 34cm X 34cm





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GUANGZHOU PANYU LAPLING ELECTRONICS CO LTD NO.1 GUANGYI RD WESTEN INDUSTRIAL AREA NANSHA ETDZ PANYU GUANGZHOU CHINA

The following sample(s) was/were submitted and identified on behalf of the clients as : LAMP LED

SGS Job No.	:	12132628 - GZ
Date of Sample Received	:	22 Jan 2009
Testing Period	:	22 Jan 2009 - 03 Feb 2009
Test Requested	:	Selected test(s) as requested by client.
Test Method	:	Please refer to next page(s).
Test Results	:	Please refer to next page(s).

Signed for and on behalf of SGS-CSTC Ltd.

Sunny Huang Lab Sr. Supervisor

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Test Report	No. CANEC0904450201	Date: 27 Aug 2009	Page 2 of 7	
Test Results:				
ID for specimen 1	: CAN09-044502.001			
Description for specimen 1	: Transparent body (mixed)			

Heavy metal(s)

Test Item(s)	Unit	Test Method (Reference)	Result	MDL
Cadmium (Cd)	mg/kg	IEC 62321:2008, ICP-OES	N.D.	2
Lead (Pb)	mg/kg	IEC 62321:2008, ICP-OES	N.D.	2
Mercury (Hg)	mg/kg	IEC 62321:2008, ICP-OES	N.D.	2
Hexavalent Chromium (CrVI) by	mg/kg	IEC 62321:2008, UV-Vis	N.D.	2
alkaline extraction				

Note:

1. mg/kg = ppm 2. N.D. = Not Detected (< MDL) 3. MDL = Method Detection Limit

Halogen

Test Item(s)	Unit	Test Method (Reference)	Result	MDL
Fluorine (F)	mg/kg	BS EN 14582:2007, IC	N.D.	50
Chlorine (Cl)	mg/kg	BS EN 14582:2007, IC	650	50
Bromine (Br)	mg/kg	BS EN 14582:2007, IC	N.D.	50
lodine (I)	mg/kg	BS EN 14582:2007, IC	N.D.	50

Note:

1. mg/kg = ppm

2. N.D. = Not Detected (< MDL)

3. MDL = Method Detection Limit

Flame Retardants

Test Item(s)	Unit	Test Method (Reference)	Result	MDL
Sum of PBBs	mg/kg	-	N.D.	-
Monobromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Dibromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Tribromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Tetrabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Pentabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Hexabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5

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Test Item(s)	Unit	Test Method (Reference)	Result	MDL
Heptabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Octabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Nonabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Decabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Sum of PBDEs	mg/kg	-	N.D.	-
Monobromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Dibromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Tribromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Tetrabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Pentabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Hexabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Heptabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Octabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Nonabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5
Decabromodiphenyl ether ##	mg/kg	IEC 62321:2008, GC-MS	N.D.	5

Note:

1. mg/kg = ppm

2. N.D. = Not Detected (< MDL)

3. MDL = Method Detection Limit

4. "-" = Not regulated

5. ## = The exemption of DecaBDE in polymeric application according 2005/717/EC was overruled by the European Court of Justice by its decision of 01.04.2008. Subsequently DecaBDE is included in the sum of PBDE after 01.07.2008

PFOA & PFOS (Perfluorooctanoic acid & Perfluorooctane sulfonates)

Test Item(s)	Unit	Test Method (Reference)	Result	MDL
Perfluorooctanoic acid (PFOA) Perfluorooctane sulfonates (PFOS)	mg/kg mg/kg	EPA 3540C: 1996, LC-MS EPA 3540C: 1996, LC-MS	N.D. N.D.	10 10

PFOS Acid PFOS Metal Salt PFOS Amide

Note: 1. mg/kg = ppm 2. N.D. = Not Detected (< MDL) 3. MDL = Method Detection Limit

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Reference Information: Directive 2006/122/EC

(1) May not be placed on the market or used as a substance or constituent of preparations in a concentration equal to or higher than 0.005 % by mass.

(2) May not be placed on the market in semi-finished products or articles, or parts thereof, if the concentration of PFOS is equal to or higher than 0.1 % by mass calculated with reference to the mass of structurally or microstructurally distinct parts that contain PFOS or, for textiles or other coated materials, if the amount of PFOS is equal to or higher than 1µg /m2 of the coated material.

Remark1 : As requested by client, the test was conducted as whole / part sample, for the sample can't be disjointed.

Remark2: Results and photo(s) of this report refer to test report CANEC0900283301.

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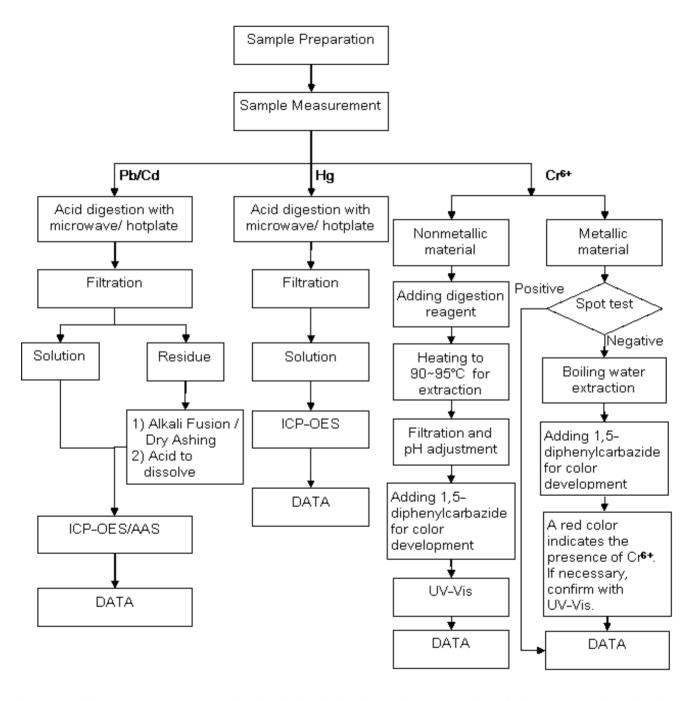
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ATTACHMENTS

Testing Flow Chart

1) Name of the person who made measurement: Luke Xu / Lily Lee 👘

2) Name of the person in charge of measurement: Adams Yu / Leo Wang



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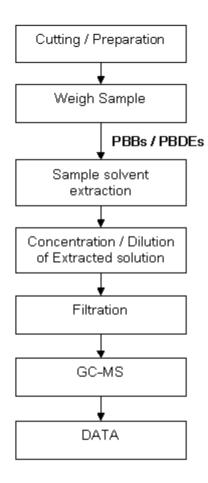
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Testing Flow Chart

1) Name of the person who made measurement: Lina Tang

2) Name of the person in charge of measurement: Tina Zhao



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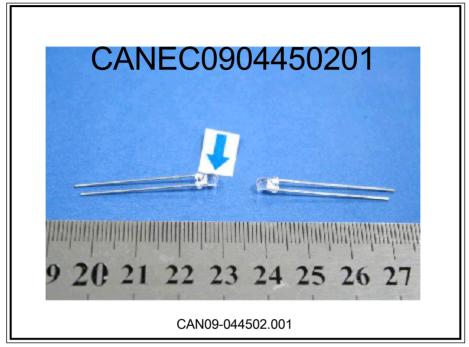


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Sample photo:



SGS authenticate the photo on original report only *** End of Report ***

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